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An Astigmatic Detection System for Polymeric Cantilever-Based Sensors

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1. Introduction

Cantilever-based sensors have emerged as a promising label-free detection technique, which have been used for high-precision mass detection and biomolecular recognition. By surface functionalization, the cantilever can be modified specific to certain compounds detection. Molecules adsorbed to one side of the cantilever will deflect the cantilever due to changes in surface stress [1–3]. Alternatively, minute mass changes can be detected by monitoring the resonant frequency change of the cantilever for high-precision mass detections [4]. By monitoring surface stress changes, for example, DNA hybridization [5] and antibiotic-peptide binding [6] have been detected.

For detecting the vibrational amplitude and/or the deflection of a microcantilever, diverse methods such as optical [7], capacitive [8], piezoresistive and piezoelectric [9–11] have been applied. The optical lever technique, typically used in atomic force microscopy (AFM), is the most popular method for detecting deflections of micromechanical structures. A laser beam is focused on a microcantilever which reflects the beam onto a position-sensitive detector (PSD).

The distance between the microcantilever and the PSD magnifies the angular detection sensitivity that subnanometer cantilever deflections can be resolved [12, 13]. The optical lever technique needs a tedious and time-consuming adjustment process before measuring each cantilever own bending angle. Therefore, the optical lever method may not be an optimum solution for new technological tasks such as fast or simultaneous detection on large microcantilever arrays. Moreover, the laser spot size in most commercially available optical lever systems is several micrometers, which is difficult to measure submicrometer-sized cantilevers. The resonant frequency of SU-8 microcantilevers is measured by both thermal fluctuation and excited vibration measurement modes of the ADS.

Previously, an astigmatic detection system (ADS) is applied in an AFM system [14] for monitoring the AFM probes. The key component of the ADS is an optical head inside a DVD ROM drive. We have demonstrated that the atomic-scale thermal noise of an AFM probe can be measured by the ADS. In this work, we combine the ADS with an optical microscope (OM) for measuring microcantilever-based sensors made of polymer SU-8 [15].

The detection scheme of the ADS is shown in Figure 1(a). Through a collimator and an objective lens, a laser beam...
generated by a laser diode (LD) is focused onto a cantilever. The cantilever reflects the laser beam back through a beam splitter, which perpendicularly reflects the laser beam onto the photodetector integrated chip (PDIC). The optoelectronic energy transformation is carried out by four independent photosensitive quadrants (A, B, C, D), which generate the signals of $S_A$, $S_B$, $S_C$, and $S_D$, respectively. When the ADS is focused on the cantilever, the laser spot on PDIC is circular shaped. The defocus distance $\Delta z$ of the object induces a shape change of the laser spot, as shown in Figure 1(b). A corresponding focus error signal $S_{FE}$ is defined as $S_{FE} = (S_A + S_C) - (S_B + S_D)$. For monitoring and accurate aligning the laser spot on the object, an OM with CMOS sensor, is combined to the optical path of the ADS.

Without angular adjustment, the ADS can still measure resonance frequencies of cantilevers with bending angle from $-8$- to $8$-degree deviation. Compared with the optical lever technique, the large angular tolerance of the ADS makes high-speed measurement possible [16]. One of the main challenges is to be able to measure the resonant peak of the polymer cantilevers without reflective coatings. This would represent a very useful tool for employing the technology to out-of-the-lab applications, drastically reducing the size and cost of the readout setup. Furthermore, the SU-8 microcantilevers without coating can substantially simplify the manufacturing process and reduce the cost of the microcantilever-based biosensor. In this paper, we measure the resonant frequency of the microcantilevers in four conditions: with and without reflective coating and with and without external excitation.

2. SU-8 Microcantilevers Dynamic Analysis

Our developed microcantilevers are made of polymer SU-8, which possesses the advantages of simple processing, low Young’s modulus for high force resolution and low sensitivity to the environmental temperature [17]. Figure 2 shows an SEM image of eight SU-8 microcantilevers on one chip. Each microcantilever is 495 $\mu$m long, 100 $\mu$m wide, and 5.3 $\mu$m thick. On the free end of each microcantilever is a circular coated gold pad with a diameter of 50 $\mu$m and a thickness of 20 nm. The gold pads provide well-reflective surfaces for the optical detection.

In order to validate the performance of the ADS, analytical models and finite element methods (FEM-) are used to calculate the resonant frequencies of the SU-8 microcantilevers. Their mechanical properties are mainly influenced by shape, materials, and geometrical sizes. The spring constant and the fundamental resonant frequency of
Table 1: Mechanical properties and dimensions of an SU-8 microcantilever.

<table>
<thead>
<tr>
<th>Property</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>$E$</td>
<td>$4.2 \pm 0.5$ GPa</td>
</tr>
<tr>
<td>$\rho$</td>
<td>$1200$ kg/m$^3$</td>
</tr>
<tr>
<td>$L$</td>
<td>$495$ $\mu$m</td>
</tr>
<tr>
<td>$W$</td>
<td>$100$ $\mu$m</td>
</tr>
<tr>
<td>$T$</td>
<td>$5.3 \pm 0.1$ $\mu$m</td>
</tr>
</tbody>
</table>

Table 2: Simulated resonant frequencies by using FEMLAB.

<table>
<thead>
<tr>
<th>Mode</th>
<th>Frequency (kHz)</th>
</tr>
</thead>
<tbody>
<tr>
<td>First bending mode</td>
<td>$6.59 \pm 0.5$</td>
</tr>
<tr>
<td>Second bending mode</td>
<td>$41.3 \pm 3.3$</td>
</tr>
<tr>
<td>Torsional mode</td>
<td>$66.2 \pm 5.2$</td>
</tr>
</tbody>
</table>

a homogeneous rectangular microcantilever in vacuum can be approximated by (1) and (2), respectively [18]:

$$k = \frac{EwT^3}{4L^3}, \quad (1)$$

$$f_{1st} = 0.162 \sqrt{\frac{E}{\rho L^2}}, \quad (2)$$

Table 1 lists the mechanical properties and geometrical sizes of the SU-8 microcantilevers [19]. Based on these values, the calculated spring constant $k$ and resonant frequency $f_{1st}$ of the microcantilever are $0.128 \pm 0.02$ N/m and $6.55 \pm 0.4$ kHz, respectively.

By using finite element analysis software (FEMLAB), simulated resonant frequencies are listed in Table 2. The first bending mode frequency of the microcantilever is 6.43 kHz, which well-matches the theoretical value 6.55 ± 0.4 kHz calculated by (2).

The resonant frequency of the microcantilever is shifted by its mass change due to absorption of specific target molecules. For realizing a high mass sensitivity, the binding region for the target molecule can be confined to the free end of the microcantilever. The bound mass variation $\Delta m$ can be associated with $f_{1st}$ and the frequency variation $\Delta f$, as shown in

$$\Delta m = \frac{k}{4\pi^2} \left( \frac{1}{(f_{1st} + \Delta f)^2} - \frac{1}{f_{1st}^2} \right). \quad (3)$$

When $\Delta f$ and the $\Delta m$ are close to zero, (3) can be simplified as (4), which describes the sensitivity of the mass variation $\Delta m$ to the frequency variation $\Delta f$:

$$\frac{\Delta m}{\Delta f} = -\frac{k}{2\pi^2 f_{1st}^3}. \quad (4)$$

From the calculated spring constant $k = 0.128 \pm 0.02$ N/m and resonant frequency $f_{1st}$ 6.55 ± 0.4 kHz, we can derive a sensitivity $\Delta m/\Delta f$ of $-23.2$ pg/Hz. Higher resonant frequency of the microcantilever can significantly enhance the measurement resolution of the mass. For a constant sampling rate, increasing the number of sampling data can also improve the measurement resolution of frequency, but it will slow down the measurement speed.

3. Experimental Setup

Figure 3 illustrates a block diagram of the ADS combined with an OM. Through an optomechanical adaptor, the ADS can be easily attached to the objective of the OM (Nikon Eclipse E100). The CMOS camera is employed to capture a magnified image of the cantilever and display the image on the PC monitor for controlling the alignment process. A light source from the bottom can illuminate the microcantilevers for enhancing the contrast of the optical image.

The ADS is based on a slim type DVD optical head which has a size of $50 \times 35 \times 6$ mm. The laser diode of the ADS generates a laser beam with a wavelength of 655 nm. The aspheric objective lens of the optical head with a numeric aperture (NA) of 0.6 has a focal length of 2.33 mm. However, the NA 0.6 objective has a working distance of only 1.28 mm, which may limit some measurement application. The working distance can be enlarged by replacing smaller NA objective lens. The NA 0.16 objective lens has a much longer working distance of 12 mm. The linear detection range of the NA 0.6 and NA 0.16 objective lens is 6 $\mu$m and 320 $\mu$m, respectively.

The full width at half-maximum (FWHM) $D_w$ of the focal spot is given by

$$D_w = 0.52 \frac{\lambda}{NA}. \quad (5)$$

The calculated $D_w$ of NA 0.6 and NA 0.16 objective lenses are 568 nm and 2.13 $\mu$m (FWHM), respectively. The NA 0.6 objective lens with submicron laser spot is beneficial to detect deflections of submicrometer-sized cantilevers.

Additionally, the PDIC has a bandwidth of 80 MHz (−3 dB) that is suitable to high-frequency detection. The SFEE calibration procedure can be done by giving cantilever a known vertical displacement directly. Overall, the ADS with NA 0.6 and NA 0.16 object lenses has a measurement sensitivity of 0.5 nm/mV and 50 nm/mV, respectively. Because of higher measurement resolution, most of the measurements in this paper are carried out by the ADS with NA 0.6 objective lens.

The preamplifier is used to amplify and transform the signals from the PDIC into the focus error signal $S_{FE}$ which is then processed by a high-speed 14-Bit DAQ card (PCI-9820, ADLINK) with a sampling rate up to 130 MHz (ping-pong mode). Through the PCI bus, the digital data is analyzed by a program under a LabVIEW (National Instruments) platform. The acquired vibrational signal is processed by the fast Fourier transformation (FFT). Using the FFT algorithm, the acquired time domain signal is transformed into the frequency domain spectrum, which gives a clear overview of all resonant frequencies.

For improving the signal to noise ratio (SNR), microcantilevers are typically coated with high reflective materials like gold. However, the reflective layer may also cause binding of undesired molecules and might induce unwanted bimorph effects.

Furthermore, pure SU-8 surfaces can be employed for measuring thermodynamic properties of polymer thin films...
deposited on the cantilevers surfaces [20]. Fast screening of the vibrational behavior of pure SU-8 microcantilevers would represent an extremely useful tool for the analysis of mechanical properties of polymeric material and for monitoring of degradation processes of biopolymers under various conditions [21].

The resonant frequencies of the microcantilevers are measured by the ADS in four conditions: with and without reflective coating; with and without external excitation. As expected, the SNR is strongly reduced when neither reflective pads nor external actuation is involved. The vibrational amplitude and the SNR of microcantilevers without reflective coatings can be significantly improved by the external excitation. In our experiments, a PZT actuator which is driven by a function generator is attached to a holder of the microcantilevers.

Figure 3: Block diagram of the ADS attached to an OM.

Figure 4: Microscopic images of (a) circular gold pad on SU-8 microcantilever and (b) focusing laser spot on gold pad.
Figure 4 (a) shows an optical microscope image of the 20 nm thick circular gold pad on the free end of an SU-8 microcantilever. Through the X, Y, Z coarse stages of the OM, the laser beam is positioned and focused at the detected gold pad. And the focusing process can be simultaneously monitored as shown in Figure 4 (b). The laser alignment can be adjusted with an x-y resolution of 100 nm.

4. Results and Discussion

Figure 5(a) shows the thermal noise spectrum and the fundamental resonant peak of the microcantilever. For measuring low resonance frequency cantilever, the bandwidth of the preamplifier we used is 1 MHz only, thus the measured signal decayed in the end. For precise identifying the resonant peak, the spectral data are fitted by the simple harmonic oscillator (SHO) function as shown in Figure 5(b). The measured resonant frequency 6.328 kHz is close to the calculated result range of $6.55 \pm 0.4$ kHz from (2) and the FEA simulated result of $6.59 \pm 0.5$ kHz. The difference may be attributed to damping effects, which are neglected in the simplified theoretical models. Furthermore, the values for Young’s modulus and density of the polymer depend on the SU-8 microfabrication-processing [22, 23] conditions.
SNR of the driving voltage of the PZT actuator. 

External excitation and can be suppressed by decreasing the value of 40.3 kHz. The 2nd harmonic is visible due to the resonant frequency is slightly smaller than the simulated resonant peak at 40 kHz is intensified. The measured second 4 times higher than without excitation. Also, the second harmonic is visible due to the external excitation can be used to intensify the SNR. The measured results coincide well with corresponding calculations and simulations. The ADS integrated with the OM and the CMOS camera makes the cantilever alignment and laser focusing efficient. For low reflective cantilever surface, the external excitation can be used to intensify the SNR.

Compared with the optical lever technique, the ADS has more advantages for high-speed microcantilever deflection measurements, such as compact size, easy adjustment, and high angular tolerance. Furthermore, the ADS with different objective lens is suitable for submicrometer cantilevers and long distance measurement applications. In future work, the ADS will be used to measure surface acoustic waves (SAWs) [24], which are widely applied in wireless devices as well as in chemical/biological sensors.

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**References**


**5. Conclusions**

The ADS is capable of measuring the resonance frequency of SU-8 microcantilevers with and without reflective coatings.


